

BRAINWARE UNIVERSITY

Term End Examination 2021 - 22 Programme – Diploma in Electronics & Communication Engineering Course Name – Power Electronics Course Code - DECE605C (Semester VI)

Time allotted: 1 Hrs.15 Min. Full Marks: 60

[The figure in the margin indicates full marks.]

Group-A

0 = 60

(Multiple Choice)	Type Question)	1 x 60=6
Choose the correct alternative from the following:		
(1) In a three-phase half wave rectifier usually, the prima because	ary side of the transformer is delta connected	
a) it has no neutral connection	b) we can get greater output voltage	
c) it provides a path for the triplen harmonics	d) it provides better temperature stability	
(2) In a three-phase half wave diode rectifier using 3 diod	des, each diode conducts for	
a) 90 degrees	b) 120 degrees	
c) 180 degrees	d) 360 degrees	
(3) In a three-phase half wave 6-pulse mid-point type did	ode rectifier, each diode conducts for	
a) 120°	b) 60°	
c) 90°	d) 180°	
(4) A 3-phase bridge rectifier, has the average output vol of line voltage	tage as 286.48 V. Find the maximum value	
a) 100 V	b) 200 V	
c) 300 V	d) 400 V	
(5) In a single pulse semi-converter using two SCRs, the	triggering circuit must produce	
a) two firing pulses in each half cycle	b) one firing pulse in each half cycle	
c) three firing pulses in each cycle	d) one firing pulse in each cycle	
(6) In the complete firing circuit, the driver circuit consis	ets of	
a) pulse generator & power supply	b) gate leads & power supply	
c) pulse amplifier & pulse transformer	d) pulse detector & pulse amplifier	
(7) The magnitude of gate voltage and gate current for tr	iggering an SCR is	
a) inversely proportional to the temperature	b) directly proportional to the temperature	;
c) inversely proportional to the anode current require ment	 d) directly proportional to the anode curre ment 	nt require
(8) The major function of the pulse transformer is to		

a) increase the voltage amplitude	b) reduce narmonics	
c) isolate low & high power circuit	d) create periodic pulses	
(9) A p-type semiconductor material is doped with impurition	impurities whereas a n-type semic	
a) acceptor, donor	b) acceptor, acceptor	
c) donor, donor	d) donor, acceptor	
(10) The n-region has a greater concentration oftion diode.	as compared to the p-region in a P-N junc	
a) holes	b) electrons	
c) both holes & electrons	d) phonons	
(11) In the p & n regions of the p-n junction the ge carriers respectively.	_ & the are the minority char	
a) holes, holes	b) electrons, electrons	
c) holes, electrons	d) electrons, holes	
(12) Which of the following is true in case of an unbiased	p-n junction diode?	
a) Diffusion does not take placec) There is zero electrical potential across the junctio ns	b) Diffusion of electrons & holes goes on infinitelyd) Charges establish an electric field across the junct ions	
(13) An ideal power diode must have		
a) low forward current carrying capacity	b) large reverse breakdown voltage	
c) high ohmic junction resistance	d) high reverse recovery time	
(14) Power diode is		
a) a three terminal semiconductor device	b) a two terminal semiconductor device	
c) a four terminal semiconductor device	d) a three terminal analog device	
(15) Which of the following is true in case of a power diod	le with R load?	
a) I grows almost linearly with V	b) I decays almost linearly with V	
c) I is independent of V	d) I initial grows than decays	
(16) A diode is said to be forward biased when the		
a) cathode is positive with respect to the anode	b) anode is positive with respect to the cathode	
c) anode is negative with respect to the anode	d) both cathode & anode are positive	
(17) A power diode with small softness factor (S-factor) has	as	
a) small oscillatory over voltages	b) large oscillatory over voltages	
c) large peak reverse current	d) small peak reverse current	
(18) At turn-on the initial delay or turn on delay is the time	e required for the	
a) input inductance to charge to the threshold value	b) input capacitance to charge to the threshold value	
c) input inductance to discharge to the threshold valu	d) input capacitance to discharge to the threshold value	
(19) Choose the correct statement		
a) MOSFET suffers from secondary breakdown prob lems	b) MOSFET has lower switching losses as compared to other devices	
 c) MOSFET has high value of on-state resistance as compared to other devices 	d) All of the mentioned	
(20) Which among the following devices is the most suited	for high frequency applications?	
a) BJT	b) IGBT	
c) MOSFET	d) SCR	
(21) For a MOSFET Vgs=3V, Idss=5A, and Id=2A. Find the pinch of voltage Vp		
a) 4.08	b) 8.16	

c) 16.32	d) 0V
(22) The basic advantage of the CMOS technology is that	
a) It is easily available	b) It has small size
c) It has lower power consumption	d) It has better switching capabilities
(23) The MOSFET combines the areas of &	
a) field effect & MOS technology	b) semiconductor & TTL
c) mos technology & CMOS technology	d) none of the mentioned
(24) The arrow on the symbol of MOSFET indicates	
a) that it is a N-channel MOSFET	b) the direction of electrons
c) the direction of conventional current flow	d) that it is a P-channel MOSFET
(25) The controlling parameter in MOSFET is	
a) Vds	b) Ig
c) Vgs	d) Is
(26) In the internal structure of a MOSFET, a parasitic BJ	Γ exists between the
a) source & gate terminals	b) source & drain terminals
c) drain & gate terminals	d) there is no parasitic BJT in MOSFET
(27) In the transfer characteristics of a MOSFET, the thres	hold voltage is the measure of the
 a) minimum voltage to induce a n-channel/p-channel for conduction 	b) minimum voltage till which temperature is constant
c) minimum voltage to turn off the device	d) none of the above mentioned is true
(28) The output characteristics of a MOSFET, is a plot of	
a) Id as a function of Vgs with Vds as a parameter	b) Id as a function of Vds with Vgs as a parameter
c) Ig as a function of Vgs with Vds as a parameter	d) Ig as a function of Vds with Vgs as a parameter
(29) A power transistor is a	
a) three layer, three junction device	b) three layer, two junction device
c) two layer, one junction device	d) four layer, three junction device
(30) A power transistor is a device.	
a) two terminal, bipolar, voltage controlled	b) two terminal, unipolar, current controlled
c) three terminal, unipolar, voltage controlled	d) three terminal, bipolar, current controlled
(31) In a power transistor, the IB vs VBE curve is	
a) a parabolic curve	b) an exponentially decaying curve
c) resembling the diode curve	d) a straight line $Y = IB$
(32) The forward current gain α is given by	
a) IC/IB	b) IC/IE
c) IE/IC	d) IE/IB
(33) A power BJT is used as a power control switch by bia the saturation region (on state). In the on state	asing it in the cut off region (off state) or in
 a) both the base-emitter & base-collector junctions a re forward biased 	b) the base-emitter junction is reverse biased, and the base collector junction is forward biased
 c) the base-emitter junction is forward biased, and the e base collector junction is reversed biased 	d) both the base-collector & the base-emitter junctions are reversed biased
(34) The power electronics devices have a very high effici	ency because
a) cooling is very efficient	b) the devices traverse active region at high speed & stays at the two states, on and off
c) the devices never operate in active region	d) the devices always operate in the active region
(35) High frequency operation of any device is limited by	the

a) forward voltage rating	b) switching losses
c) thermal conductivity	d) heat Sink arrangements
36) A 1mv of i/p gives an output of 1V, the voltage gai	in as such would be
a) 0.001	b) 0.0001
c) 1000	d) 100
37) IGBT possess	
a) low input impedance	b) high input impedance
c) high on-state resistance	d) second breakdown problems
38) The three terminals of the IGBT are	
a) base, emitter & collector	b) gate, source & drain
c) gate, emitter & collector	d) base, source & drain
39) The controlling parameter in IGBT is the	
a) IG	b) VGE
c) IC	d) VCE
40) The voltage blocking capability of the IGBT is det	ermined by the
a) injection layer	b) body layer
c) metal used for the contacts	d) drift layer
41) The structure of the IGBT is a	
a) P-N-P structure connected by a MOS gate	b) N-N-P-P structure connected by a MOS gate
c) P-N-P-N structure connected by a MOS gate	d) N-P-N-P structure connected by a MOS gate
42) When latch-up occurs in an IGBT	· · · · · · · · · · · · · · · · · · ·
a) Ig is no longer controllable	b) Ic is no longer controllable
c) the device turns off	d) Ic increases to a very high value
43) The static V-I curve of an IGBT is plotted with	
a) Vce as the parameter	b) Ic as the parameter
c) Vge as the parameter	d) Ig as the parameter
44) The approximate equivalent circuit of an IGBT con	nsists of
a) a BJT & a MOSFET	b) a MOSFET & a MCT
c) two BJTs	d) two MOSFETs
45) The body of an IGBT consists of a	
a) p-layer	b) n-layer
c) p-n layer	d) metal
46) At present, the state-of-the-art semiconductor devi	ces are begin manufactured using
a) Semiconducting Diamond	b) Gallium-Arsenide
c) Germanium	d) Silicon-Carbide
47) Which terminal does not belong to the SCR?	,
a) Anode	b) Gate
c) Base	d) Cathode
48) An SCR is a	,
a) four layer, four junction device	b) four layer, three junction device
c) four layer, two junction device	d) three layer, single junction device
49) Choose the false statement.	, , , , , , , , , , , , , , , , , , ,
a) SCR is a bidirectional device	b) SCR is a controlled device
c) In SCR the gate is the controlling terminal	d) SCR are used for high-power applications
50) In the SCR structure the gate terminal is located	, 6 1
,	

a) near the anode terminal	b) near the cathode terminal
c) in between the anode & cathode terminal	d) none of the mentioned
51) The static V-I curve for the SCR is plotted for	
a) Ia (anode current) vs Ig (gate current), Va (anode – cathode voltage) as a parameter	b) Ia vs Va with Ig as a parameter
c) Va vs Ig with Ia as a parameter	d) Ig vs Vg with Ia as a parameter
52) If the cathode of an SCR is made positive with respective hen	et to the anode & no gate current is applied t
a) all the junctions are reversed biased	b) all the junctions are forward biased
c) only the middle junction is forward biased	d) only the middle junction is reversed biased
53) With the anode positive with respect to the cathode & in the	the gate circuit open, the SCR is said to be
a) reverse blocking mode	b) reverse conduction mode
c) forward blocking mode	d) forward conduction mode
54) The forward break over voltage is the	
a) anode-cathode voltage at which conduction starts with gate signal applied	b) anode-cathode voltage at which conduction starts with no gate signal applied
 c) gate voltage at which conduction starts with no an ode-cathode voltage 	d) gate voltage at which conduction starts with anod e-cathode voltage applied
55) For a forward conducting SCR device, as the forward	anode to cathode voltage is increased
a) the device turns on at higher values of gate curren t	b) the device turns on at lower values of gate current
c) the forward impedance of the device goes on increasing	d) the forward impedance of the device goes on decreasing
56) A thyristor can be bought from the forward conduction	on mode to forward blocking mode by
a) the dv/dt triggering method	b) applying a negative gate signal
c) applying a positive gate signal	d) applying a reverse voltage across anode-cathode t erminals
57) Usually the forward voltage triggering method is not	used to turn-on the SCR because
a) it increases losses	b) it causes noise production
c) it may damage the junction & destroy the device	d) relatively it's an inefficient method
58) The forward break over voltage is maximum when	
a) Gate current = ∞	b) Gate current = 0
c) Gate current = $-\infty$	d) It is independent of gate current
59) The value of anode current required to maintain the c ignal is removed is called as the	onduction of an SCR even though the gate s
a) holding current	b) latching current
c) switching current	d) peak anode current
60) In the reverse blocking mode the middle junction (J2)) has the characteristics of that of a
a) transistor	b) capacitor
c) inductor	d) inductor